

PATENT  
450100-05304

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicants: Yutaka SATO et al.  
International Application No.: PCT/JP2004/015197  
International Filing Date: October 7, 2004  
For: LIGHT AMOUNT CONTROL APPARATUS AND  
CAMERA APPARATUS

745 Fifth Avenue  
New York, NY 10151

**EXPRESS MAIL**

Mailing Label Number: EV845291755US

Date of Deposit: April 20, 2006

I hereby certify that this paper or fee is being deposited with the  
United States Postal Service "Express Mail Post Office to  
Addressee" Service under 37 CFR 1.10 on the date indicated above  
and is addressed to Mail Stop PCT, Commissioner for Patents,  
P.O. Box 1450, Alexandria, VA 22313-1450.

Barnet Shindler  
(Typed or printed name of person mailing paper or fee)  
Bulshein  
(Signature of person mailing paper or fee)

**INFORMATION DISCLOSURE STATEMENT**

Mail Stop PCT  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Enclosed are copies of the publications, which were cited in the International  
Search Report of International Application No. PCT/JP2004/015197. Also enclosed is a copy  
of Form PTO-1449 and the International Search Report.

10/576395  
AP20 REG'D PCT/US03 APR 2006  
PATENT NO. 450100-05304

REMARKS

Entry of this Information Disclosure Statement and an early examination on the  
merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

FROMMER LAWRENCE & HAUG LLP  
Attorneys for Applicants

By:   
William S. Frommer  
Reg. No. 25,506  
Tel. (212) 588-0800

Enclosures

Based on Form PTO-1449 (3/90)		ATTY. DOCKET NO. 450100-05304	SERIAL NO. <b>16395</b> Filed Concurrently Herewith
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)		APPLICANT Yutaka SATO et al.	
		FILING DATE Filed Concurrently Herewith	GROUP

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
AA							
AB							
AC							
AD							
AE							
AF							
AG							
AH							
AI							
AJ							
AK							

## FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
/Y.A./	AL	JP 2003-131189	05/08/03	Japan			
/Y.A./	AM	JP 6-54253	02/25/94	Japan			
	AN						
	AO						
	AP						

## OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	AQ		
	AR		
	AS		
EXAMINER	/Yogesh Aggarwal/		DATE CONSIDERED 12/05/2008

\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.